# **BUK763R6-40C**

# N-channel TrenchMOS standard level FET

Rev. 04 — 16 June 2010

**Product data sheet** 

### 1. Product profile

### 1.1 General description

Standard level gate drive N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using advanced TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in high performance automotive applications.

#### 1.2 Features and benefits

- AEC Q101 compliant
- Avalanche robust

- Suitable for standard level gate drive
- Suitable for thermally demanding environment up to 175°C rating

### 1.3 Applications

- 12V Motor, lamp and solenoid loads
- High performance automotive power systems
- High performance Pulse Width Modulation (PWM) applications



### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol               | Parameter  | Conditions  |            | Min | Тур | Max | Unit |
|----------------------|--|---|------------|-----|-----|-----|------|
| $V_{DS}$             | drain-source<br>voltage                            | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$   |            | -   | -   | 40  | V    |
| I <sub>D</sub>       | drain current                                      | $V_{GS}$ = 10 V; $T_{mb}$ = 25 °C;<br>see <u>Figure 1</u> ; see <u>Figure 3</u>                                       | <u>[1]</u> | -   | -   | 100 | Α    |
| P <sub>tot</sub>     | total power dissipation                            | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>  |            | -   | -   | 203 | W    |
| Static cha           | racteristics                                       |   |            |     |     |     |      |
| R <sub>DSon</sub>    | drain-source<br>on-state<br>resistance             | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$<br>$T_j = 25 \text{ °C};$<br>see <u>Figure 11</u> ; see <u>Figure 12</u> |            | -   | 3   | 3.6 | mΩ   |
| Avalanche            | ruggedness   |   |            |     |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive<br>drain-source<br>avalanche energy | $I_D$ = 100 A; $V_{sup} \le 40$ V;<br>$R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V;<br>$T_{j(init)}$ = 25 °C; unclamped   |            | -   | -   | 292 | mJ   |
| Dynamic o            | characteristics                                    |   |            |     |     |     |      |
| $Q_{GD}$             | gate-drain charge                                  | $V_{GS}$ = 10 V; $I_D$ = 25 A;<br>$V_{DS}$ = 32 V; $T_j$ = 25 °C;<br>see <u>Figure 14</u> ; see <u>Figure 13</u>      |            | -   | 35  | -   | nC   |

<sup>[1]</sup> Continuous current is limited by package.

# 2. Pinning information

Table 2. Pinning information

|     | •                                   |             |                    |                |
|-----|-------------------------------------|-------------|--------------------|----------------|
| Pin | Symbol                              | Description | Simplified outline | Graphic symbol |
| 1   | G                                   | gate        |                    |                |
| 2   | D                                   | drain       | mb                 | D              |
| 3   | S                                   | source      |                    | G (EX)         |
| mb  | D mounting base; connected to drain |             | mbb076 S           |                |
|     |                                     |             | SOT404 (D2PAK)     |                |

# 3. Ordering information

Table 3. Ordering information

| Type number  | Package |  |         |
|--------------|---------|--|---------|
|              | Name    | Description  | Version |
| BUK763R6-40C | D2PAK   | plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped) | SOT404  |

# 4. Limiting values

Table 4. Limiting values

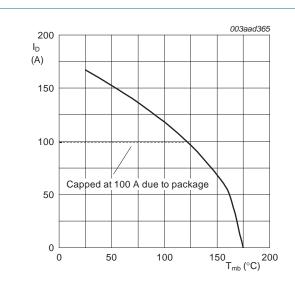
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol               | Parameter  | Conditions  |            | Min | Тур | Max | Unit |
|----------------------|--|---|------------|-----|-----|-----|------|
| $V_{DS}$             | drain-source voltage                               | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C   |            | -   | -   | 40  | V    |
| $V_{DGR}$            | drain-gate voltage                                 | $R_{GS} = 20 \text{ k}\Omega$   |            | -   | -   | 40  | V    |
| $V_{GS}$             | gate-source voltage                                |   | <u>[1]</u> | -20 | -   | 20  | V    |
| I <sub>D</sub>       | drain current                                      | $T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>                                  | [2]        | -   | -   | 167 | Α    |
|                      |  | T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; see <u>Figure 1</u>   | [3]        | -   | -   | 100 | Α    |
|                      |  | $T_{mb}$ = 25 °C; $V_{GS}$ = 10 V; see <u>Figure 1</u> ; see <u>Figure 3</u>                                  | [3]        | -   | -   | 100 | Α    |
| I <sub>DM</sub>      | peak drain current                                 | $T_{mb}$ = 25 °C; $t_p$ ≤ 10 μs; pulsed; see Figure 3   |            | -   | -   | 668 | Α    |
| P <sub>tot</sub>     | total power dissipation                            | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>  |            | -   | -   | 203 | W    |
| T <sub>stg</sub>     | storage temperature                                |   |            | -55 | -   | 175 | °C   |
| Tj                   | junction temperature                               |   |            | -55 | -   | 175 | °C   |
| Source-drain         | diode  |   |            |     |     |     |      |
| Is                   | source current                                     | T <sub>mb</sub> = 25 °C   | [3]        | -   | -   | 100 | Α    |
|                      |  |   | [2]        | -   | -   | 167 | Α    |
| I <sub>SM</sub>      | peak source current                                | $t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$  |            | -   | -   | 668 | Α    |
| Avalanche ru         | ggedness   |   |            |     |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive<br>drain-source<br>avalanche energy | $I_D$ = 100 A; $V_{sup} \le$ 40 V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; unclamped |            | -   | -   | 292 | mJ   |

<sup>[1] -20</sup>V accumulated duration not to exceed 168 hrs.

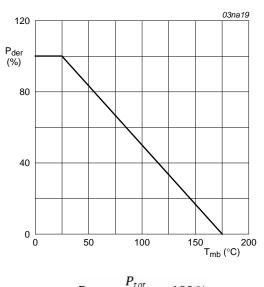
<sup>[2]</sup> Current is limited by power dissipation chip rating.

<sup>[3]</sup> Continuous current is limited by package.



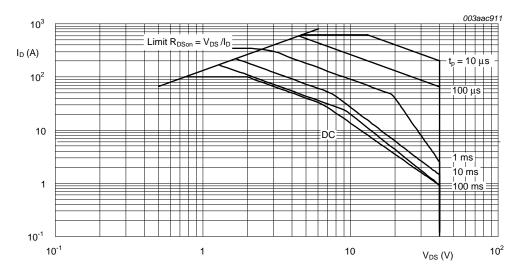
 $V_{GS} \ge 10 V(1)$  Capped at 100A due to package

Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mh} = 25$ °C;  $I_{DM}$ is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage.

### 5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol                | Parameter   | Conditions   | Min | Тур | Max  | Unit |
|-----------------------|---|--|-----|-----|------|------|
| R <sub>th(j-mb)</sub> | thermal resistance<br>from junction to<br>mounting base | see Figure 4   | -   | -   | 0.74 | K/W  |
| R <sub>th(j-a)</sub>  | thermal resistance<br>from junction to<br>ambient       | mounted on printed circuit board;<br>minimum footprint; SOT404 package | -   | -   | 50   | K/W  |

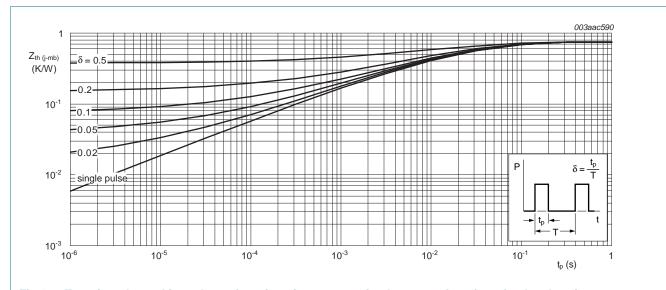
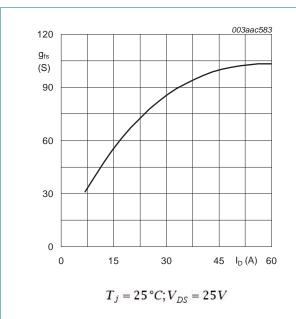


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

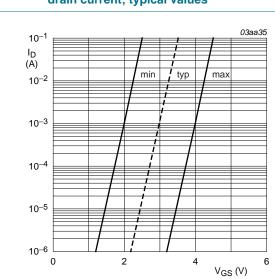
## 6. Characteristics

Table 6. Characteristics

| Table 6.                          | Characteristics                  |   |     |      |      |      |
|-----------------------------------|----------------------------------|---|-----|------|------|------|
| Symbol                            | Parameter                        | Conditions  | Min | Тур  | Max  | Unit |
| Static cha                        | racteristics                     |   |     |      |      |      |
| V <sub>(BR)DSS</sub> drain-source |                                  | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$  | 40  | -    | -    | V    |
|                                   | breakdown voltage                | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$   | 36  | -    | -    | V    |
| $V_{GS(th)}$                      | gate-source threshold voltage    | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see <u>Figure 10</u>   | 2   | 3    | 4    | V    |
|                                   |                                  | $I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 175 °C; see <u>Figure 10</u>  | 1   | -    | -    | V    |
|                                   |                                  | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see <u>Figure 10</u>  | -   | -    | 4.4  | V    |
| $I_{DSS}$                         | drain leakage current            | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$   | -   | -    | 500  | μΑ   |
|                                   |                                  | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$  | -   | 0.02 | 1    | μΑ   |
| I <sub>GSS</sub>                  | gate leakage current             | $V_{DS} = 0 \text{ V}; V_{GS} = 20 \text{ V}; T_j = 25 \text{ °C}$  | -   | 2    | 100  | nA   |
|                                   |                                  | $V_{DS} = 0 \text{ V}; V_{GS} = -20 \text{ V}; T_j = 25 \text{ °C}$   | -   | 2    | 100  | nΑ   |
| R <sub>DSon</sub>                 | drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 25 \text{ A}; T_j = 175 °C;$<br>see <u>Figure 11</u>  | -   | -    | 7.2  | mΩ   |
|                                   |                                  | $V_{GS}$ = 10 V; $I_D$ = 25 A; $T_j$ = 25 °C;<br>see <u>Figure 11</u> ; see <u>Figure 12</u>  | -   | 3    | 3.6  | mΩ   |
| Dynamic                           | characteristics                  |   |     |      |      |      |
| Q <sub>G(tot)</sub>               | total gate charge                | $I_D = 25 \text{ A}; V_{DS} = 32 \text{ V}; V_{GS} = 10 \text{ V};$   | -   | 97   | -    | nC   |
| Q <sub>GS</sub>                   | gate-source charge               | $T_j = 25 \text{ °C}$ ; see <u>Figure 13</u> ; see <u>Figure 14</u>   | -   | 21   | -    | nC   |
| $Q_{GD}$                          | gate-drain charge                | $I_D = 25 \text{ A}$ ; $V_{DS} = 32 \text{ V}$ ; $V_{GS} = 10 \text{ V}$ ;<br>$T_j = 25 \text{ °C}$ ; see <u>Figure 14</u> ; see <u>Figure 13</u> | -   | 35   | -    | nC   |
| C <sub>iss</sub>                  | input capacitance                | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$   | -   | 4391 | 5708 | pF   |
| Coss                              | output capacitance               | T <sub>j</sub> = 25 °C; see <u>Figure 15</u>  | -   | 800  | 1040 | pF   |
| $C_{rss}$                         | reverse transfer capacitance     |   | -   | 535  | 696  | pF   |
| t <sub>d(on)</sub>                | turn-on delay time               | $V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V};$   | -   | 40   | -    | ns   |
| t <sub>r</sub>                    | rise time                        | $R_{G(ext)} = 10 \Omega; T_j = 25 °C$   | -   | 95   | -    | ns   |
| t <sub>d(off)</sub>               | turn-off delay time              |   | -   | 129  | -    | ns   |
| t <sub>f</sub>                    | fall time                        |   | -   | 92   | -    | ns   |
| L <sub>D</sub>                    | internal drain<br>inductance     | from drain lead 6 mm from package to centre of die; $T_j = 25$ °C   | -   | 4.5  | -    | nΗ   |
|                                   |                                  | from contact screw on mounting base to centre of die; T <sub>j</sub> = 25 °C  | -   | 3.5  | -    | nΗ   |
| L <sub>S</sub>                    | internal source inductance       | from source lead to source bond pad ; $T_j = 25 ^{\circ}\text{C}$   | -   | 7.5  | -    | nΗ   |
| Source-di                         | ain diode                        |   |     |      |      |      |
| $V_{SD}$                          | source-drain voltage             | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$<br>see <u>Figure 16</u>  | -   | 0.83 | 1.2  | V    |
| t <sub>rr</sub>                   | reverse recovery time            | $I_S = 20 \text{ A}; \text{ dI}_S/\text{dt} = -100 \text{ A/}\mu\text{s};$  | -   | 44   | -    | ns   |
| Q <sub>r</sub>                    | recovered charge                 | $V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}; T_j = 25 \text{ °C}$  | -   | 57   | -    | nC   |



Forward transconductance as a function of Fig 5. drain current; typical values



Sub-threshold drain current as a function of Fig 7. gate-source voltage

 $T_j = 25 \,^{\circ}C; V_{DS} = 5V$ 

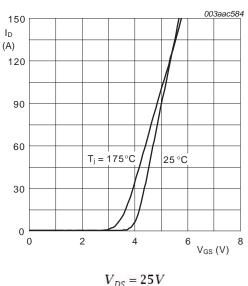
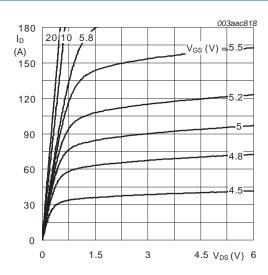


Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $T_j = 25 \,^{\circ}C; t_p = 300 \mu s$ 

Fig 8. Output characteristics: drain current as a function of drain-source voltage; typical values

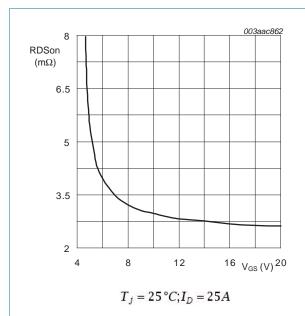


Fig 9. Drain-source on-state resistance as a function of gate voltage; typical values

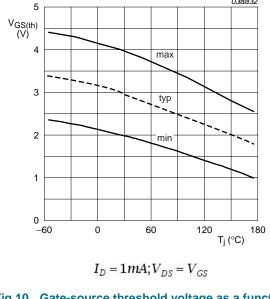


Fig 10. Gate-source threshold voltage as a function of junction temperature

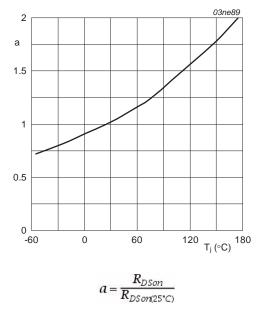


Fig 11. Normalized drain-source on-state resistance factor as a function of junction temperature

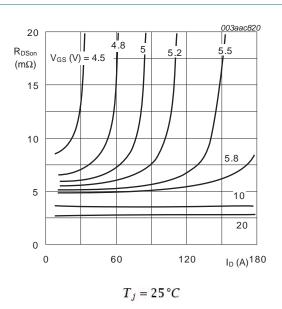
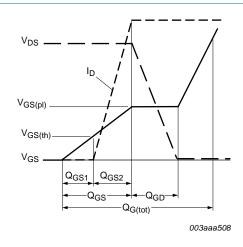


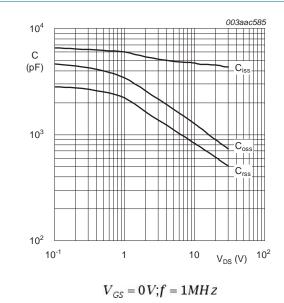
Fig 12. Drain-source on-state resistance as a function of drain current; typical values



 $T_j = 25 \,^{\circ}C$ 

Fig 13. Gate charge waveform definitions





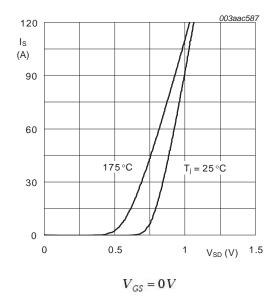


Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

Fig 16. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

## 7. Package outline

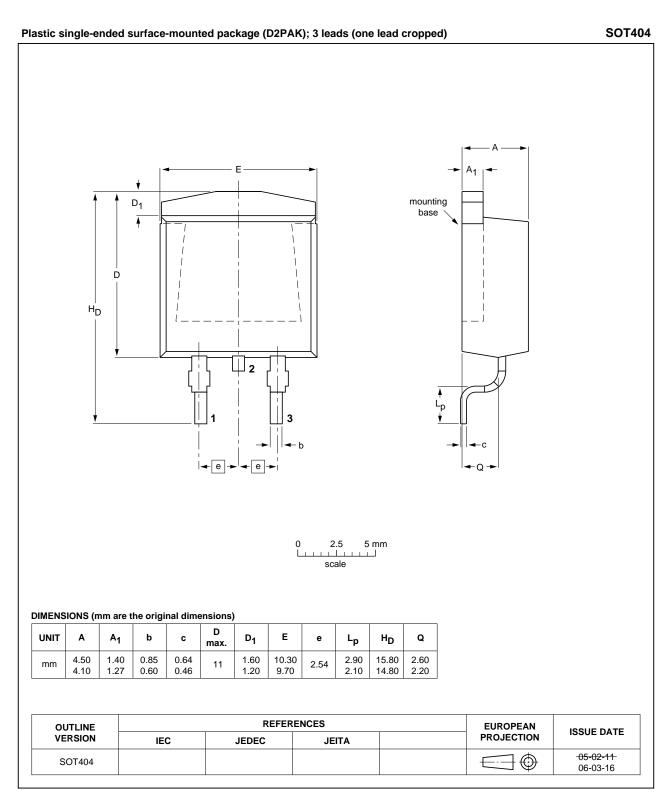


Fig 17. Package outline SOT404 (D2PAK)

# 8. Revision history

#### Table 7. Revision history

| Document ID      | Release date                    | Data sheet status  | Change notice | Supersedes       |
|------------------|---------------------------------|--------------------|---------------|------------------|
| BUK763R6-40C v.4 | 20100616                        | Product data sheet | -             | BUK763R6-40C v.3 |
| Modifications:   | <ul> <li>Various cha</li> </ul> | anges to content.  |               |                  |
| BUK763R6-40C v.3 | 20100602                        | Product data sheet | -             | -                |

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| Document status[1][2]          | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
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# **BUK763R6-40C**

#### N-channel TrenchMOS standard level FET

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